

<b>Notice of References Cited</b>	Application/Control No. 10/691,999	Applicant(s)/Patent Under Reexamination AGARWAL ET AL.	
	Examiner Ponnoreay Pich	Art Unit 2135	Page 1 of 1

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*	B	US-2003/0105771	06-2003	Tiefenbrun et al.	707/103.00R
*	C	US-6,148,377	11-2000	Carter et al.	711/147
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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